

## 4 Temperature Zone All-in-One Testing System

It can meet the Material Manufacturers, Universities and Research Institutes of multiple temperature testing requirements for Coin Cells.

- ◆ Cycle Life Test, Rate Charging / Discharging Test, GITT Test, DCIR Test, Temperature Capability, Reliability Experiment, etc.
- ◆ Integrated and connected with BTS by communication protocol, could set different temperatures and work steps.



**Space Saving**  
<0.5m<sup>2</sup>



**Voltage & Current Accuracy**  
±0.05% F.S.



**Sampling Time**  
100ms



**Number of Channels (Coin Cells)**  
4 × 16CH



**Temperature Range & Deviation**  
15°C ~ 60°C ± 2.0°C  
(No Load & Stable Temperature)



**Temperature Fluctuation**  
≤ 1°C  
(No Load & Stable Temperature)



**Heating Time**  
25°C ~ 60°C (≤ 40min)  
(No Load & Stable Temperature)



**Cooling Time**  
25°C ~ 15°C (≤ 60min)  
(No Load & Stable Temperature)



Model: MHW-25-S-16CH  
(It can be flexibly split and used separately)



Voltage & Current	Range	Range 1	Range 2	Range 3
5V/10V10mA		5μA ~ 1mA	1mA ~ 5mA	5mA ~ 10mA
5V/10V20mA		5μA ~ 1mA	1mA ~ 10mA	10mA ~ 20mA
5V/10V50mA		5μA ~ 1mA	1mA ~ 25mA	25mA ~ 50mA

\*Other models can be customized according to voltage and current requirements.



LabTech



Store



Client



Step



DataAnalyzer



Edge



LIMS



Analytics



Report



Calibration



Tele-Control & Tech-Support

Smart-Lab Solutions Platform



Tailor-Made & Worry-Free

One-Stop Purchasing Platform